Notice of References Cited

Application/Control No. 10/772,583	Applicant(s)/Pater Reexamination LIM ET AL.	nt Under
Examiner	Art Unit	
JAY P PATEI	2619	Page 1 of 1

II S PATENT DOCUMENTS

	U.S. PATENT DOCUMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0023150 A1	02-2002	Osafune et al.	709/221
*	В	US-2004/0001497 A1	01-2004	Sharma, Atul	370/401
*	С	US-2004/0001485 A1	01-2004	Frick et al.	370/389
*	D	US-7,269,663 B2	09-2007	Beier et al.	709/238
*	Е	US-2002/0186679 A1	12-2002	Nakatsugawa et al.	370/349
*	F	US-6,763,023 B1	07-2004	Gleeson et al.	370/392
*	G	US-6,856,991 B1	02-2005	Srivastava, Sunil K.	707/10
*	Н	US-7,184,421 B1	02-2007	Liu et al.	370/338
*	_	US-6,084,855	07-2000	Soirinsuo et al.	370/235
*	J	US-6,892,218 B2	05-2005	Heddaya et al.	709/202
*	К	US-7,167,922 B2	01-2007	Narayanan, Ram Gopal Lakshmi	709/242
*	L	US-7,260,638 B2	08-2007	Crosbie, David B.	709/229
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP02001119399A	04-2001	JAPAN	MATSUMOTO, SATOSHI	H04L012/28
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON DATENT DOCUMENTS

_	NON-PATENT DOCUMENTS		
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	U		
	٧		
	w		
	×		

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.